# Notice of References Cited Application/Control No. 10/007,890 Applicant(s)/Patent Under Reexamination WANG ET AL. Examiner MC 2 4 04 Art Unit Michelle R. Connelly-Cushwa 2874 Page 1 of 1

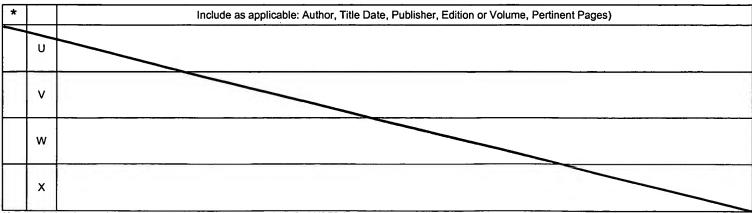
# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,212,312	04-2001	Grann et al.	385/24
	В	US-6,404,947	06-2002	Matsuda, Kenichi	385/24
	6	US-			
	D	US-			
	Ę	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1028504 A1	08-2000	European Patent	NICHOLS et al.	H01S 05/12
	6					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**



\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.

### Applicant(s)/Patent Under Application/Control No. Reexamination 10/007,890 WANG ET AL. Notice of References Cited Examiner MC 2404 Art Unit Page 1 of 1 Michelle R. Connelly-Cushwa 2874 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification MM-YYYY Country Code-Number-Kind Code US-2002/0070352 A1 06-2002 ALLAN et al. 250/492.1 Α US-US-С D US-US-Ε F US-US-G US-Н USı J US-Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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